Power MOSFET 30 V, 74 A, Single N-Channel, SO-8 FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb–Free Devices

Applications

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = $25^{\circ}C$ unless otherwise stated)

Para	Parameter			Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Volt	Gate-to-Source Voltage			±20	V
Continuous Drain Current R _{θJA}		$T_A = 25^{\circ}C$	۱ _D	16	А
(Note 1)		T _A = 85°C		11.5	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	PD	2.2	W
Continuous Drain		$T_A = 25^{\circ}C$	ID	10	А
Current R _{θJA} (Note 2)	Steady State	$T_A = 85^{\circ}C$	1	7	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.88	W
Continuous Drain		$T_{C} = 25^{\circ}C$	Ι _D	74	А
Current R _{θJC} (Note 1)		$T_{C} = 85^{\circ}C$		53	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	47.2	W
Pulsed Drain Current	t _p =10μs	$T_A = 25^{\circ}C$	I _{DM}	148	A
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to +150	°C
Source Current (Body Diode)			۱ _S	39	А
Drain to Source dV/dt			dV/dt	6	V/ns
$ \begin{array}{l} \mbox{Single Pulse Drain-to-Source Avalanche} \\ \mbox{Energy (V}_{DD} = 30 \mbox{ V, V}_{GS} = 10 \mbox{ V,} \\ \mbox{I}_L = 22 \mbox{ A}_{pk}, \mbox{ L} = 1.0 \mbox{ mH}, \mbox{ R}_G = 25 \Omega) \end{array} $			EAS	242	mJ
Lead Temperature fo (1/8" from case for 10		Purposes	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

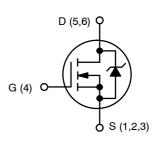
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



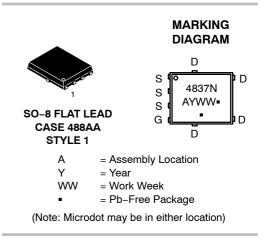
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
22.14	5.0 mΩ @ 10 V	
30 V	7.5 mΩ @ 4.5 V	74 A



N-CHANNEL MOSFET



ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4837NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4837NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	2.65	
Junction-to-Ambient - Steady State (Note 1)	R_{\thetaJA}	56.75	°C/W
Junction-to-Ambient - Steady State (Note 2)	R_{\thetaJA}	142.2	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T, I = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 µA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				25		mV/°C
Zero Gate Voltage Drain Current	$I_{DSS} \qquad V_{GS} = 0 V, \\ V_{DS} = 24 V$	T _J = 25 °C			1	1.	
		V _{DS} = 24 V	T _J = 125°C			10	μA
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)				-	-		
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$		1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.7		mV/°0
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 10 V to$	I _D = 30 A		3.5	5.0	
		11.5 V	I _D = 15 A		3.5		
		V _{GS} = 4.5 V	I _D = 30 A		5.9	7.5	mΩ
			I _D = 15 A		5.9		
Forward Transconductance	9FS	V _{DS} = 15 V, I _D = 15 A			15		S
CHARGES AND CAPACITANCES							•
Input Capacitance	C _{ISS}				2048		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH	z, V _{DS} = 12 V		444		pF
Reverse Transfer Capacitance	C _{RSS}				239		
Total Gate Charge	Q _{G(TOT)}				14.2	22	1
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			2.98		nC
Gate-to-Source Charge	Q _{GS}				5.7		
Gate-to-Drain Charge	Q _{GD}				6.7		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 11.5 V, V_{DS} = 15 V; I_{D} = 15 A			34.2		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(ON)}				14.2		

Turn-On Delay Time	t _{d(ON)}		14.2	
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 15 A,	55	20
Turn-Off Delay Time	t _{d(OFF)}	R _G = 3.0 Ω	19	ns
Fall Time	t _f		10	
Turn-On Delay Time	t _{d(ON)}		8.5	
Rise Time	t _r	V _{GS} = 11.5 V, V _{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω	25.6	20
Turn-Off Delay Time	t _{d(OFF)}	I_D = 15 A, R_G = 3.0 Ω	25.2	ns
Fall Time	t _f		9.2	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit		
DRAIN-SOURCE DIODE CHARACTERISTICS									
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V, \\ I_{S} = 30 A \\ T_{J} = 125^{\circ}C \\ T_{J} = 125^{\circ}C$			0.85	1.2	v		
					0.72				
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/μs, I _S = 30 A			24				
Charge Time	t _a				13		ns		
Discharge Time	t _b				11				
Reverse Recovery Charge	Q _{RR}				14		nC		
PACKAGE PARASITIC VALUES									
Source Inductance	L _S	- T _A = 25°C			0.93		nH		
Drain Inductance	L _D				0.005				
Gate Inductance	L _G				1.84				

2.8

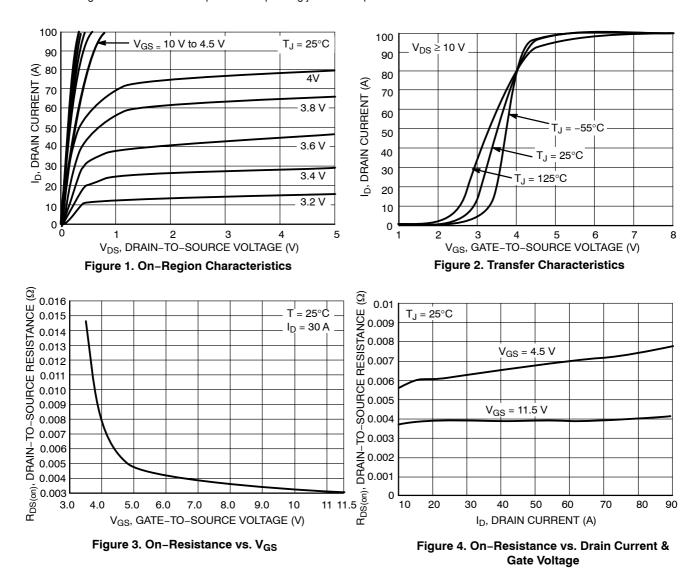
Ω

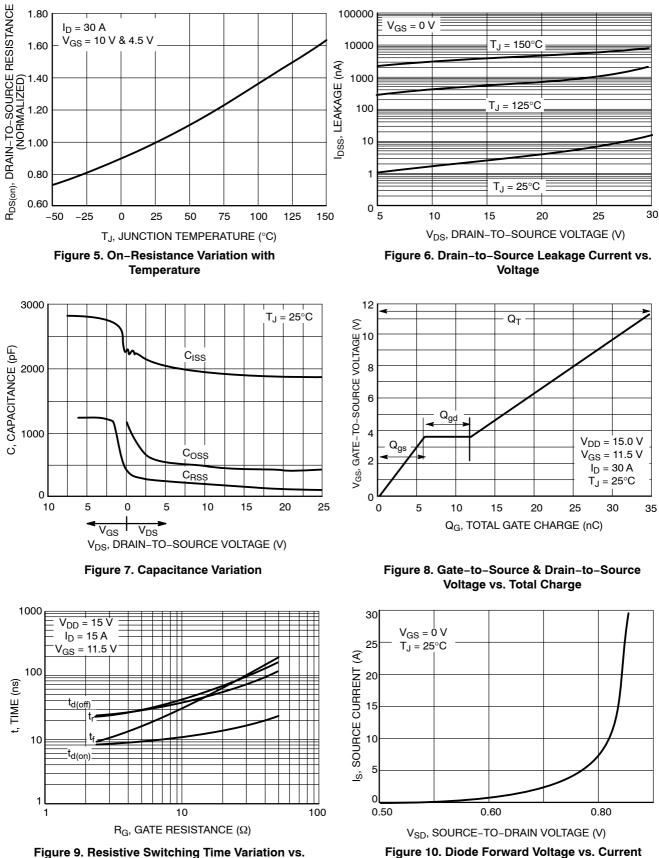
3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

Gate Resistance

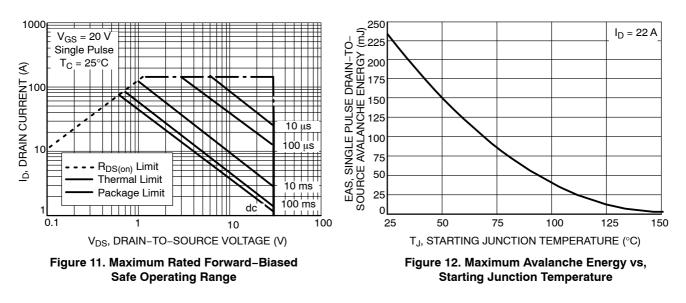
4. Switching characteristics are independent of operating junction temperatures.

 R_{G}





Gate Resistance



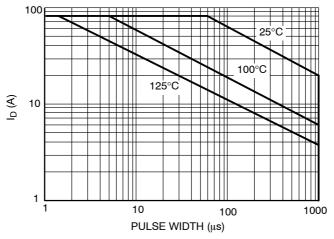
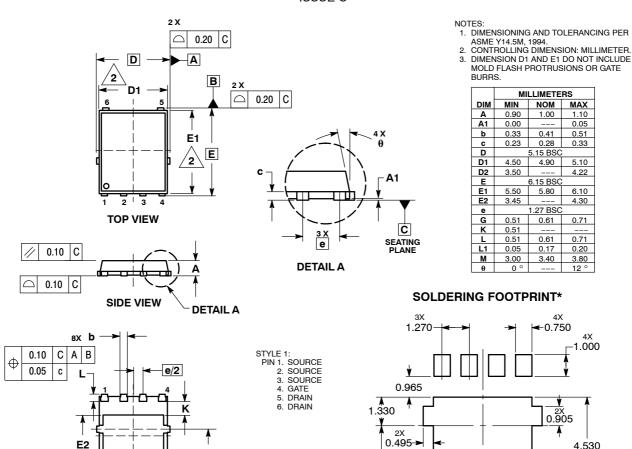


Figure 13. EAS vs. Pulse Width

PACKAGE DIMENSIONS

DFN6 5x6, 1.27P (SO8 FL) CASE 488AA-01 **ISSUE C**



0.495-> 3.200

М

D2

BOTTOM VIEW

G

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

4.560

2X → 1.530

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